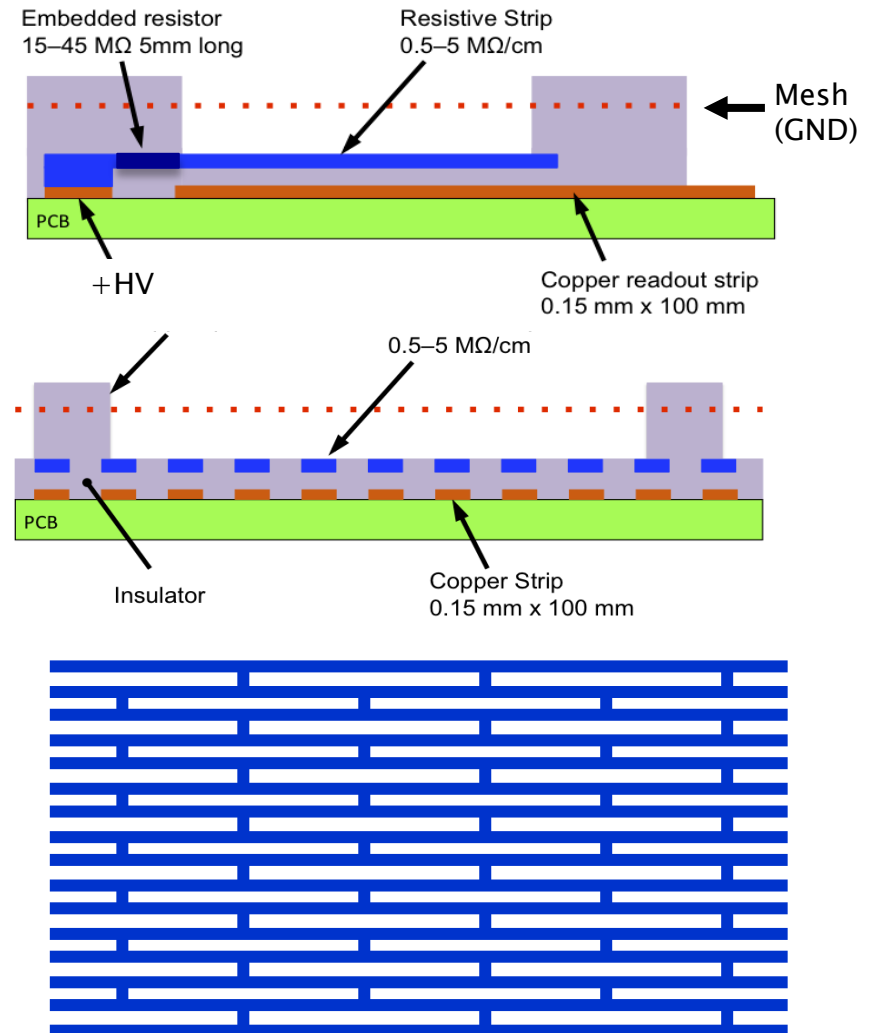


# Carbon sputtering technology for ATLAS MicroMEGAS resistive

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Takemoto<sup>1</sup>, Fumiya Yamane<sup>1</sup>, Yousuke Kataoka<sup>2</sup>,  
Tatsuya Masubuchi<sup>2</sup>, Yuki Kawanishi<sup>2</sup>, Shingo Terao<sup>2</sup>  
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# Requirements for ATLAS NSW MM

- ▶ High position resolution for one dimension
  - $< 100 \mu\text{m}$  for eta direction. (Resolution of a few cm is allowed for second coordinate.)
- ▶ Tolerant for high rate HIP particles
  - $\sim 5\text{kHz}/\text{cm}^2$
- ▶ **Resistive layer should be formed as strips**
- ▶ Resistivity:  $\sim 20\text{M}\Omega/\text{cm}$ 
  - To protect from spark
- ▶ Mass production should be available, with large size (1m)
  - $\sim 2000$  board should be produced in half year.
- ▶ Low cost



# Two option for resistive electrodes

## ▶ Screen printing

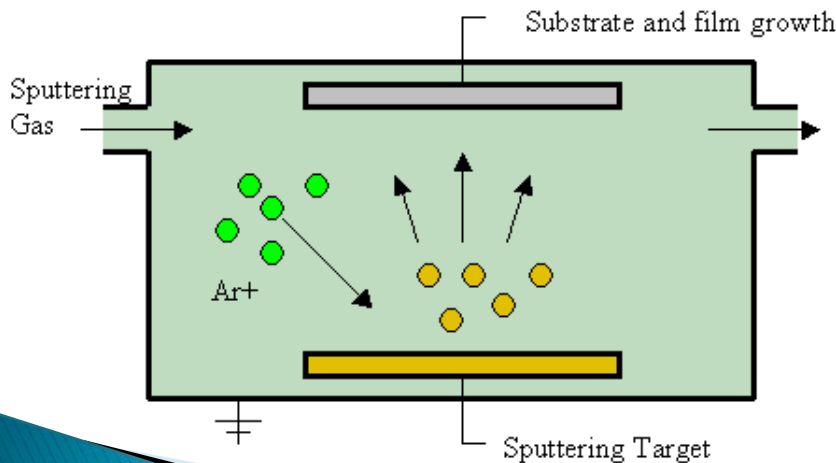
- Already several prototypes (@ CERN and Japan) has been produced.
- Made from carbon loaded polymer.
- Large size ( $> 1 \text{ m}^2$ ) is available
- 400  $\mu\text{m}$  pitch was available for MAMMA production.

## ▶ Carbon sputtering with liftoff process

- New technique. (Since 2013)
- Fine pattern ( $\sim 10 \mu\text{m}$ ) is available.
- Large size ( $> 1 \text{ m}^2$ ) is available in industrial facilities.
- Production quality is very well.
  - It is not affected by production environment

# Liftoff process using sputtering

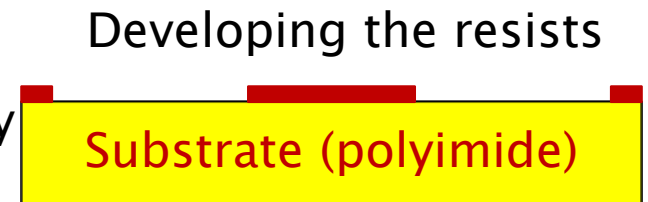
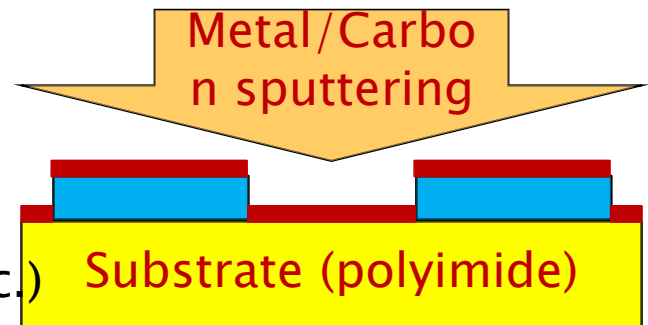
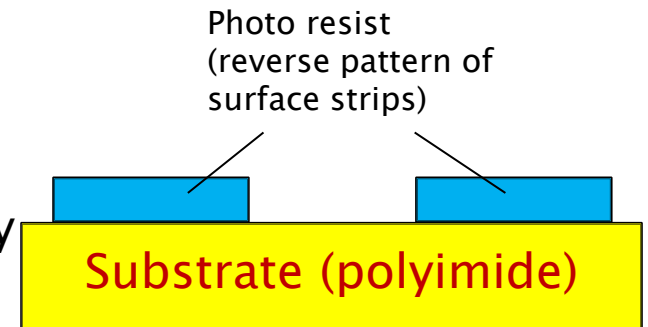
- ▶ Very fine structure (a few tens micro meter) can be formed using photo resist. (same as PCB)
- ▶ Surface resistivity can be controlled by sputtering material and their thickness



@PCB company  
(Laytech inc.)

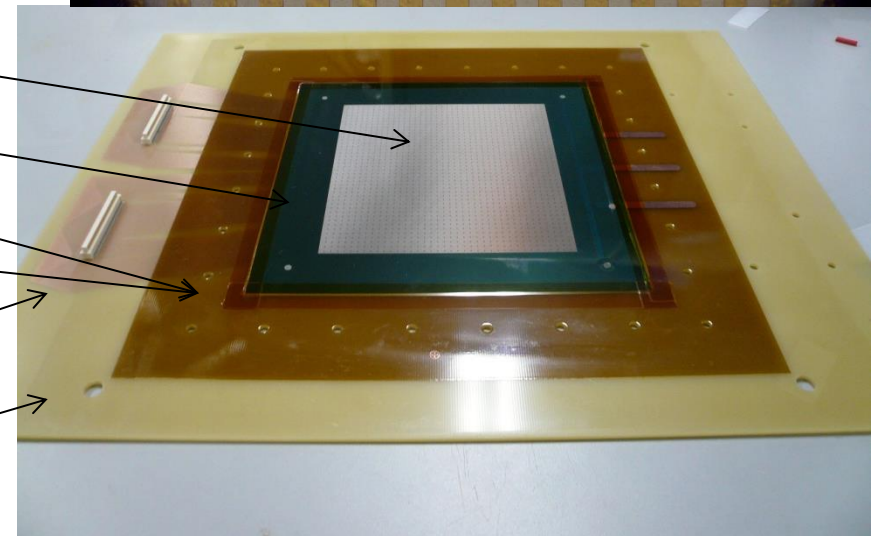
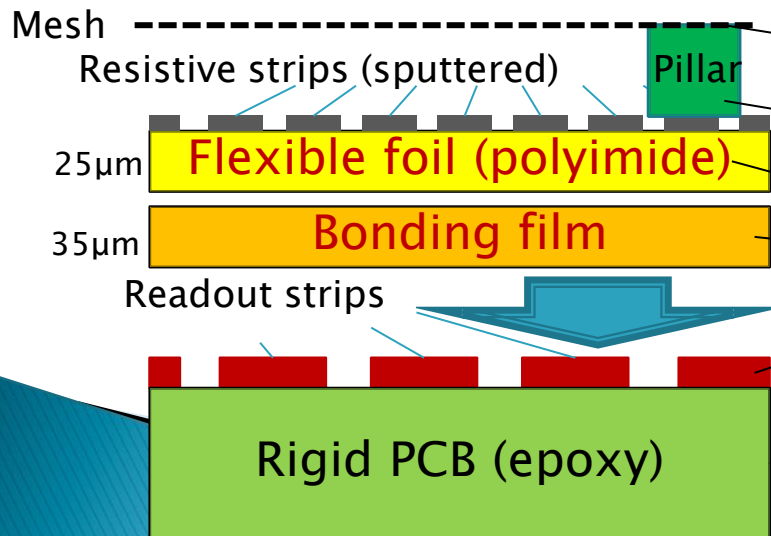
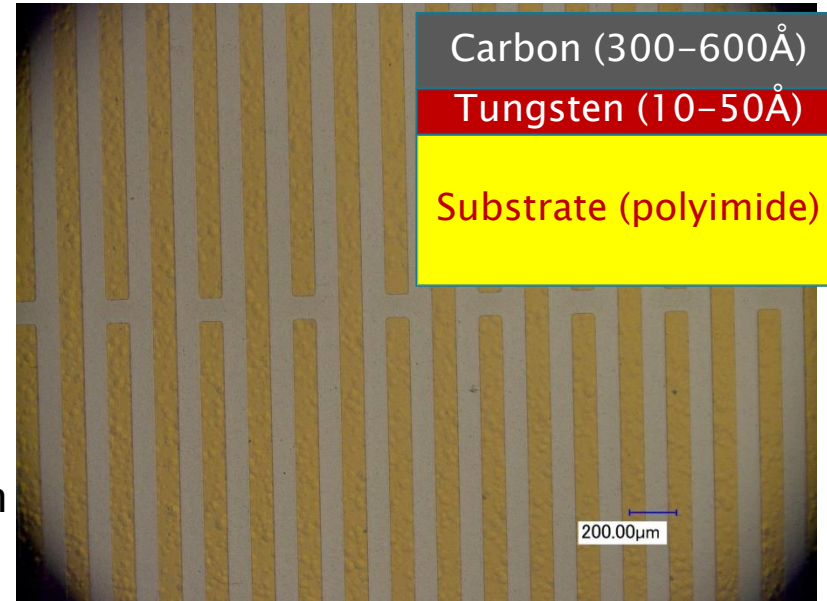
@Sputtering  
company  
(Be-Sputter inc.)

@PCB company  
(Laytech inc.)



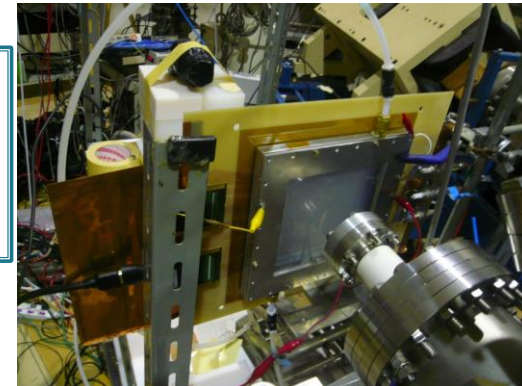
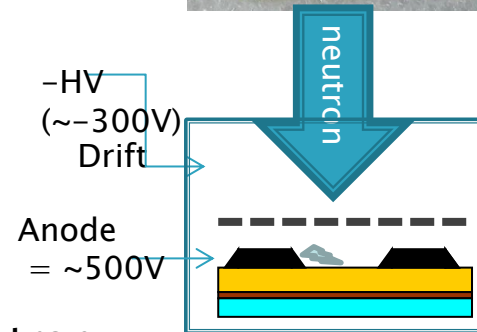
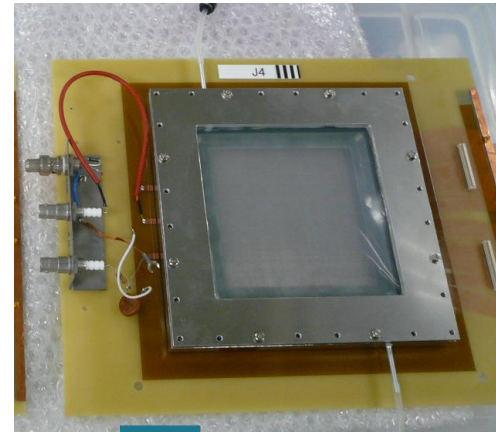
# Prototype of small MicroMEGAS

- ▶ June, 2013 – bulk MM
  - Surface resistivity:  $10\text{M}\Omega/\text{sq.}$ 
    - With  $300\text{\AA}$  carbon +  $50\text{\AA}$  W
- ▶ November, 2013 – floating mesh
  - Surface resistivity:  $500\text{k}\Omega/\text{sq.}$ 
    - With  $3600\text{\AA}$  carbon
- ▶ The readout board consists of
  - Readout strips (Rigid PCB).
  - Resistive strip foil (Polyimide film).
  - Fine strip pitch of  $200\ \mu\text{m}$  is formed on  $25\ \mu\text{m}$  polyimide foil.
  - Substrate thickness :  $60\ \mu\text{m}$ .

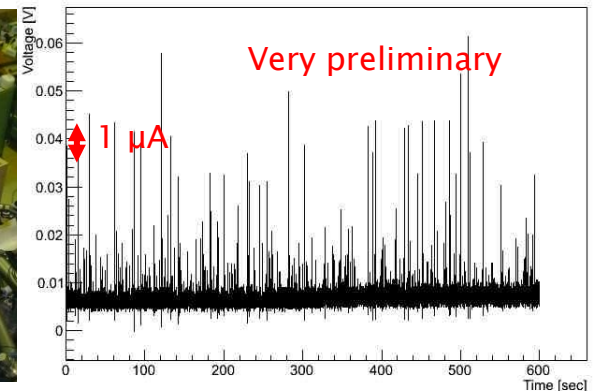
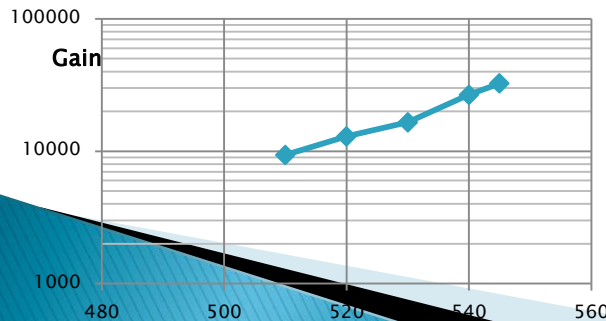


# Fast neutron test

- ▶ Beamtests for sputtering MPGD
- ▶ Gain curve of 5.9 keV X-ray.
  - Drift = -300V
  - Drift spacing: 5mm
  - Gas: Ar(93%) + CO2(7%)
- ▶ Fast Neutron test for spark probability
  - @Kobe Univ.
    - 17-23 Jun. 2013
    - 20-27 Jan. 2014
  - HV current log under intense neutron.
    - Neutron intense :  $\sim 10^5$  cps/cm<sup>2</sup>.
    - 0.01V correspond to 1  $\mu$ A
    - $\sim 600$ nA of base current was found while beam ON.



/Users/oichi/Documents/Work/mpgd/J4/current\_monitor/run231708.txt

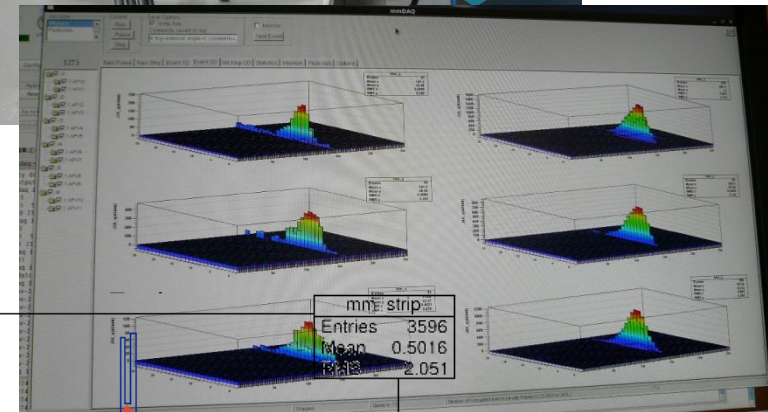
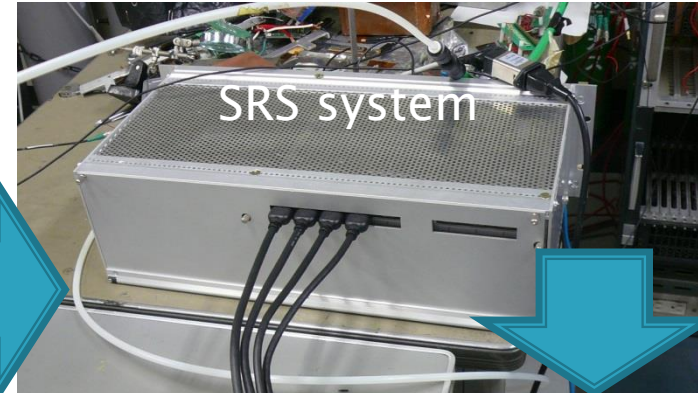
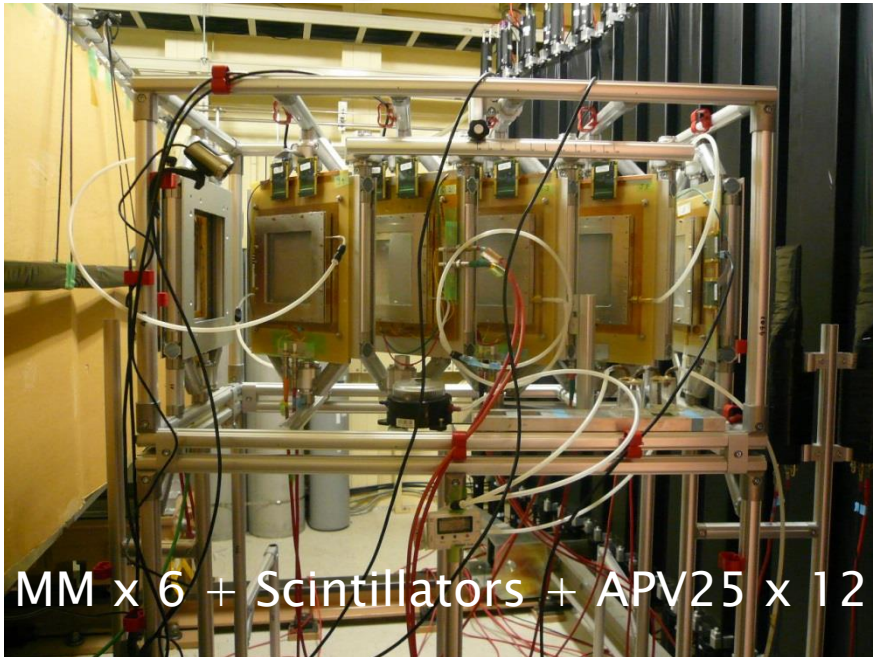


# After sparks by neutrons

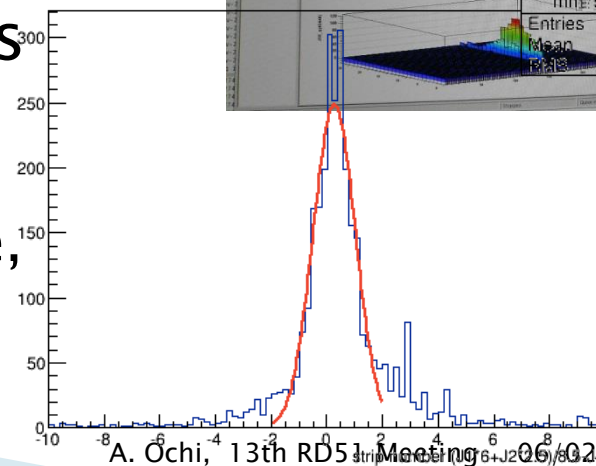
- ▶ No damage is observed on the resistive strips after neutron test



# Charged particle tracking



- ▶ Cosmic test using 4 MMs
  - At Kobe Univ, Sept. 2013
- ▶ 1.4GeV electron beam
  - At Spring-8 BL33 beamline, Nov. 2013





# Further improvements and tests for carbon sputtering

## ▶ Requirements for carbon strips

### ◦ Resistive control

- 20 M $\Omega$ /cm is required

- It correspond to 600k $\Omega$ /sq. for 300 $\mu$ m line width.

- Our first prototype has 10M $\Omega$  /sq.

- Thicker carbon sputter is required

- Long time stability of resistivity

- The resistivity of early prototypes were growing up as time goes on (~2%/day)

- It was thought that the oxidation of metal (tungsten layer)

- Is the carbon sputtering without metal layer possible?

### ◦ Mechanical / chemical robustness test

- Peeling off property (cross cut method)

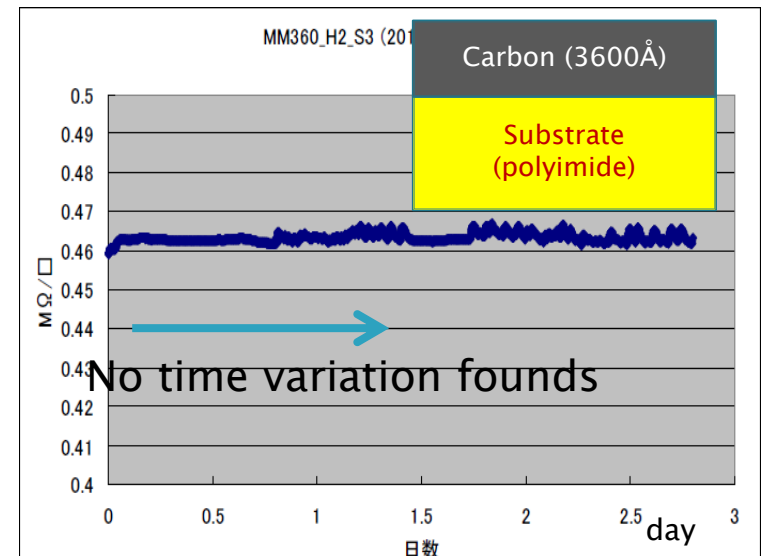
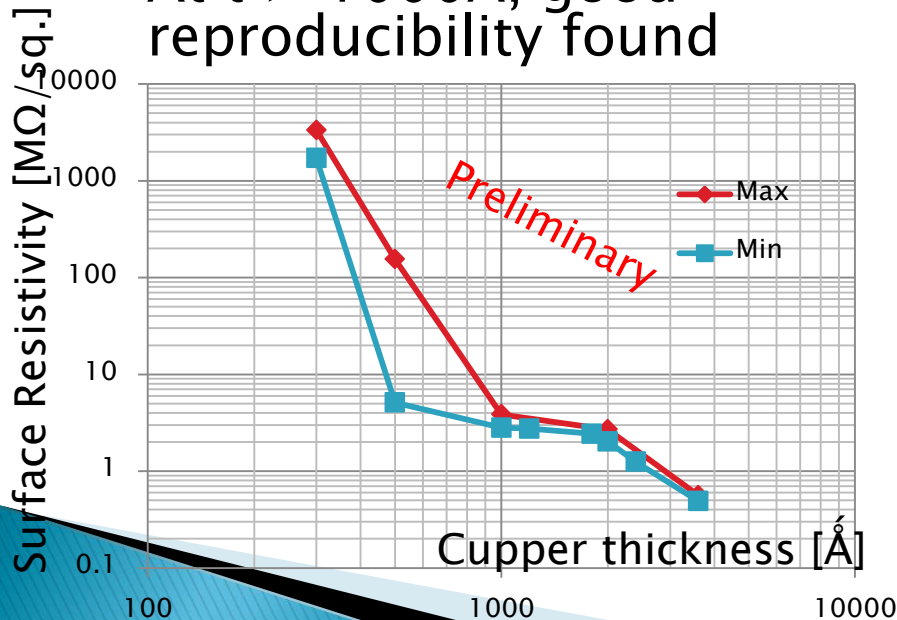
- Resistive stability against the bending of the foil

- Chemical stabilities

- For alkali and acid, used for PCB process.

# Resistivity and it's stability

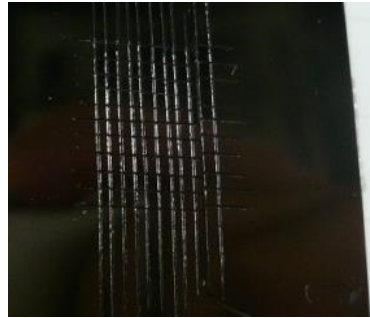
- ▶ Resistivity dependence on carbon thickness
  - $300\text{\AA} \rightarrow 2\text{G}\Omega/\text{sq.}$
  - $3600\text{\AA} \rightarrow 500\text{k}\Omega/\text{sq.}$
  - Conductivity is not proportional to the thickness ( $t < 1000\text{\AA}$ )
  - At  $t > 1000\text{\AA}$ , good reproducibility found
- ▶ New prototype: (delivered at September)
  - Carbon,  $3600\text{\AA}$
  - Surface resistivity  $\sim 500\text{k}\Omega/\text{sq.}$
  - No time variation founds after several days from sputtering



# Mechanical robustness for thick sputtering carbon

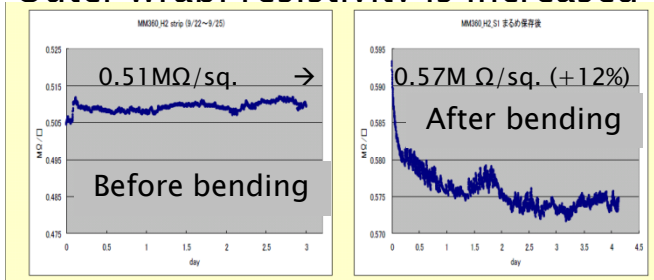
## Adhesion test

- Cross-cut test (JIS k5400-8.5 standard, similar to the ISO 2409)
- **No peeled carbon founded**

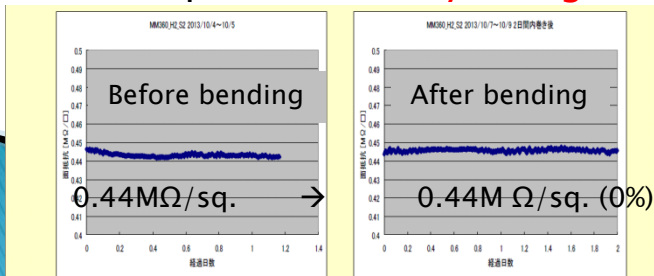


## Bending test

- **Bending diameter > 4cm** → **No resistivity change found**
- Jackknife bending → Conductivity is lost
- Bending diameter = 1.2cm → Outer wrap: resistivity is increased 10-20%

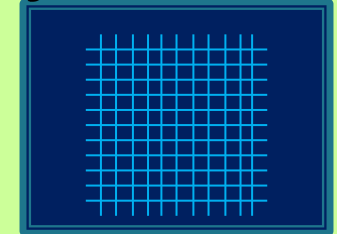


→ Inner wrap: **no resistivity change**

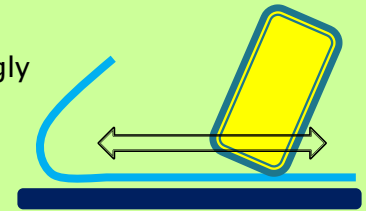


## Cross-cut test (JIS k5400-8.5)

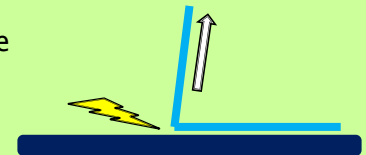
Making cut lines as grid (11 x 11, 1mm pitch)



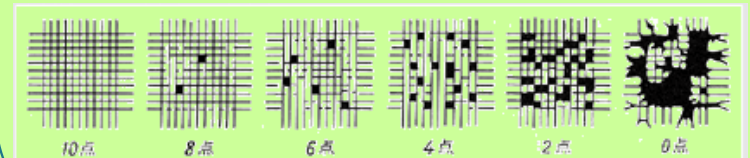
Tape up the foils strongly



Peel off the tape at once



Observe the tape and foils.



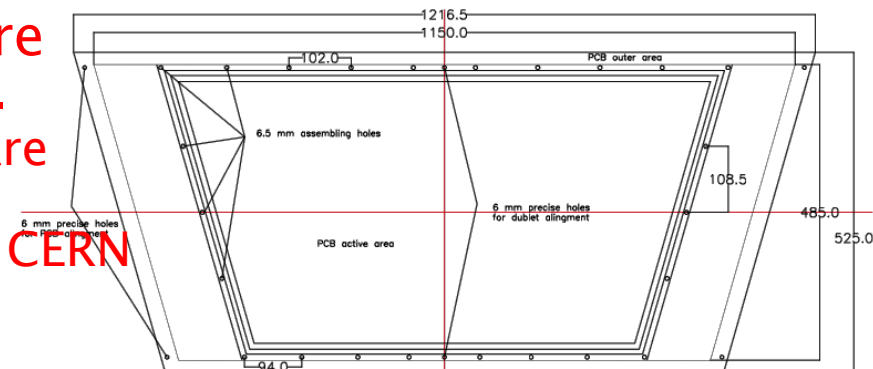
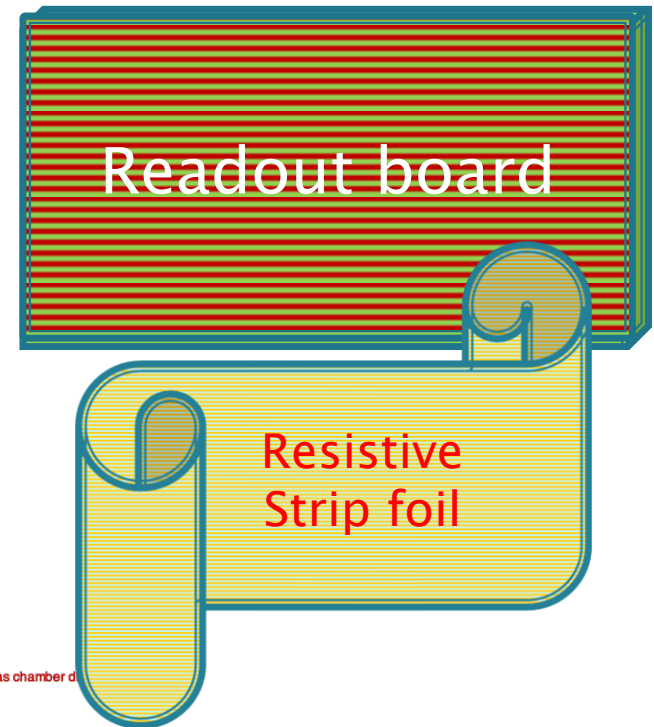
# Chemical robustness for new sputtering carbon

- ▶ Acid and alkali for PCB processing
  - Hydrochloric acid
  - Nitric acid
  - Sulfuric acid
  - Sodium carbonate
    - No damage on sputtered carbon
  - Sodium hydroxide
    - No damage for short dip
    - Peeling is found after 90 minutes dipping
- ▶ **Almost all process of PCB production will not affect to the sputtering carbon**



# Prototype of large MMs

- ▶ We can divide the production process of resistive strip from that of readout board.
  - Resistive strip is formed on thin foil
  - We don't need fine alignment between resistive strips and readout strips.
- ▶ Dividing those processes will make the yield of production growing up.
- ▶ We are preparing the large resistive strip foil.
  - Size of foils: 500mm x 1000mm
  - 4 foils are need for a quadruplet
- ▶ **8 Foils (4 foils and 4 spare) were delivered to us at 25<sup>th</sup> October.**
  - **Some basic resistive parameters are checked.**
  - **Those have been already come to CERN**



# For patterning process

**RAYTECH**

- ▶ PCB company
  - They are expert for FPC (Flexible Printed Circuit) production.
  - Liftoff is basic process for FPC production



Exposure machines  
in clean room



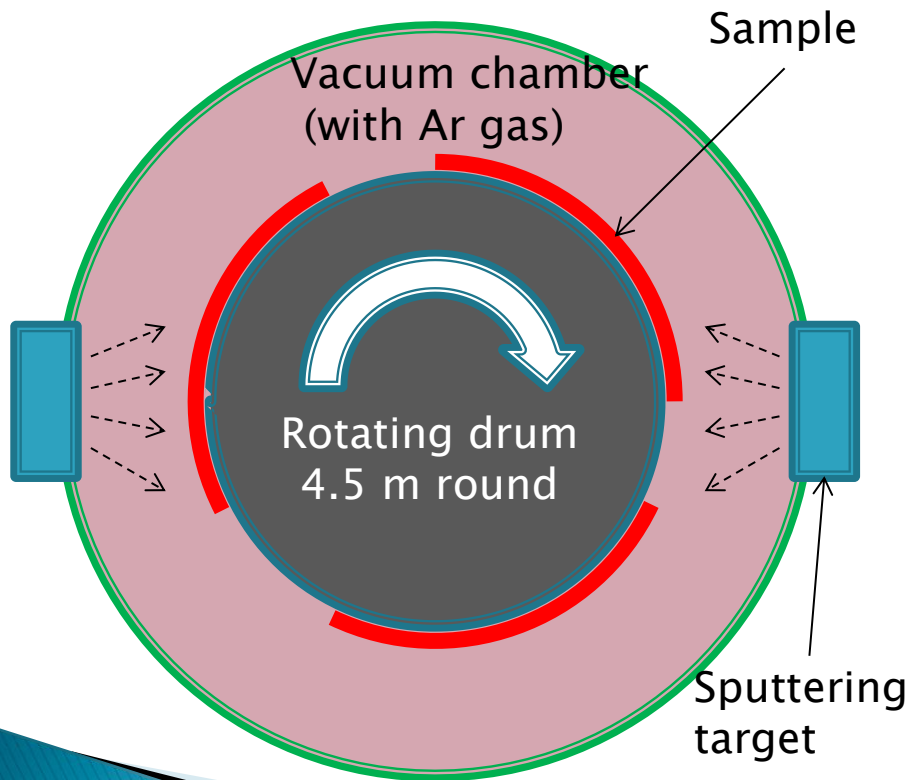
Electro forming machines



Etching machines

# Sputtering facilities

- ▶ Large size sputtering is available
  - 4.5m x 1m for flexible film



# Large resistive strip foil

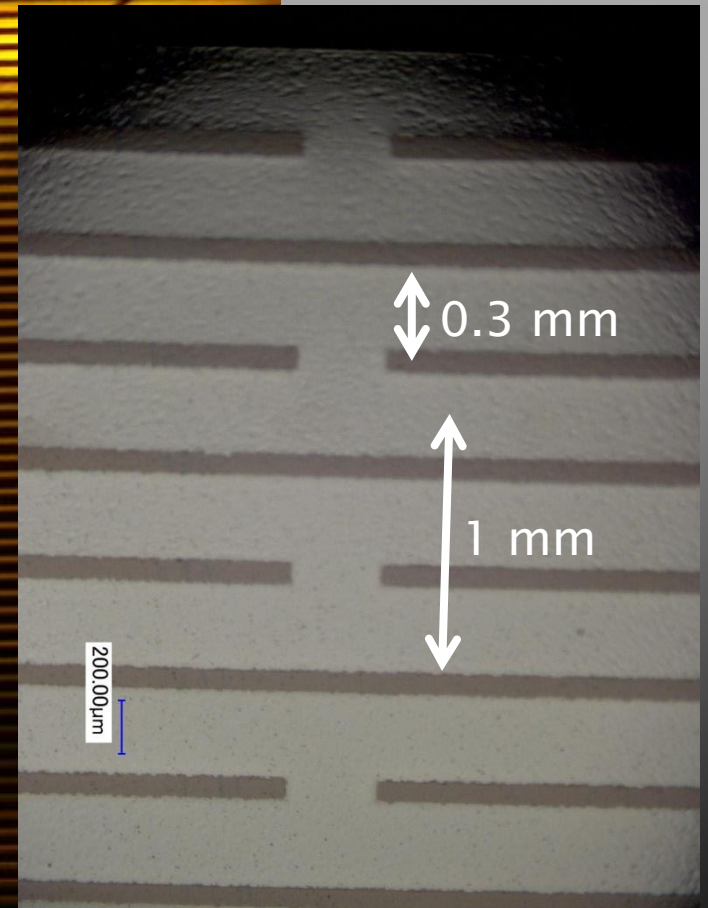
866.4mm

425.3mm



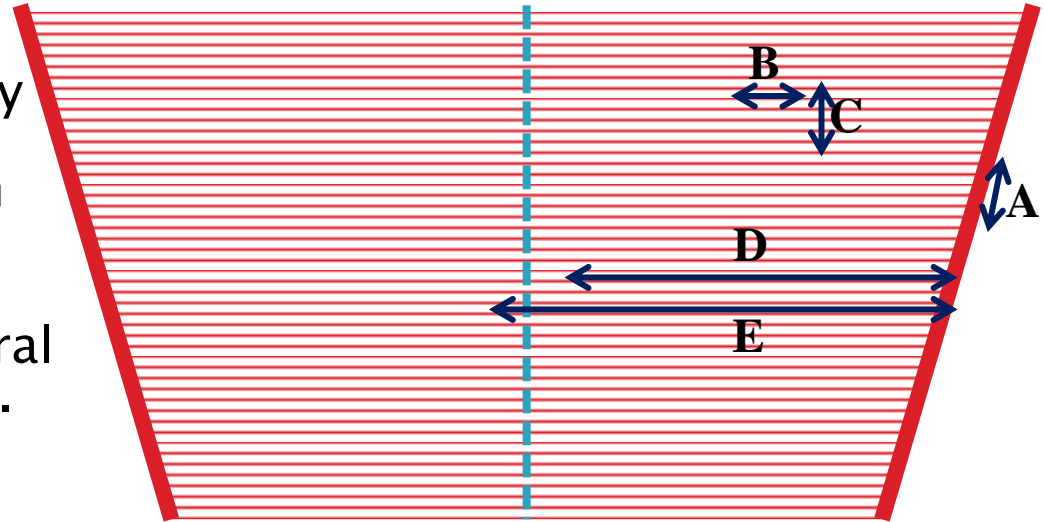
# Enlarged picture of resistive strip foil

10 mm



# Resistivity check

- ▶ We have no systematic way for resistivity test yet, so these results are based on rough measurements.
- ▶ However, we have check surface resistivity on several points for 8 foils as figure.
- ▶ The prove has about 2cm width.
- ▶ Distance between proves are, A,B,C: 1.5–2.5 cm, D: 30 cm, E: cross over a center line.
- ▶ “Inf” means more than 50MΩ.

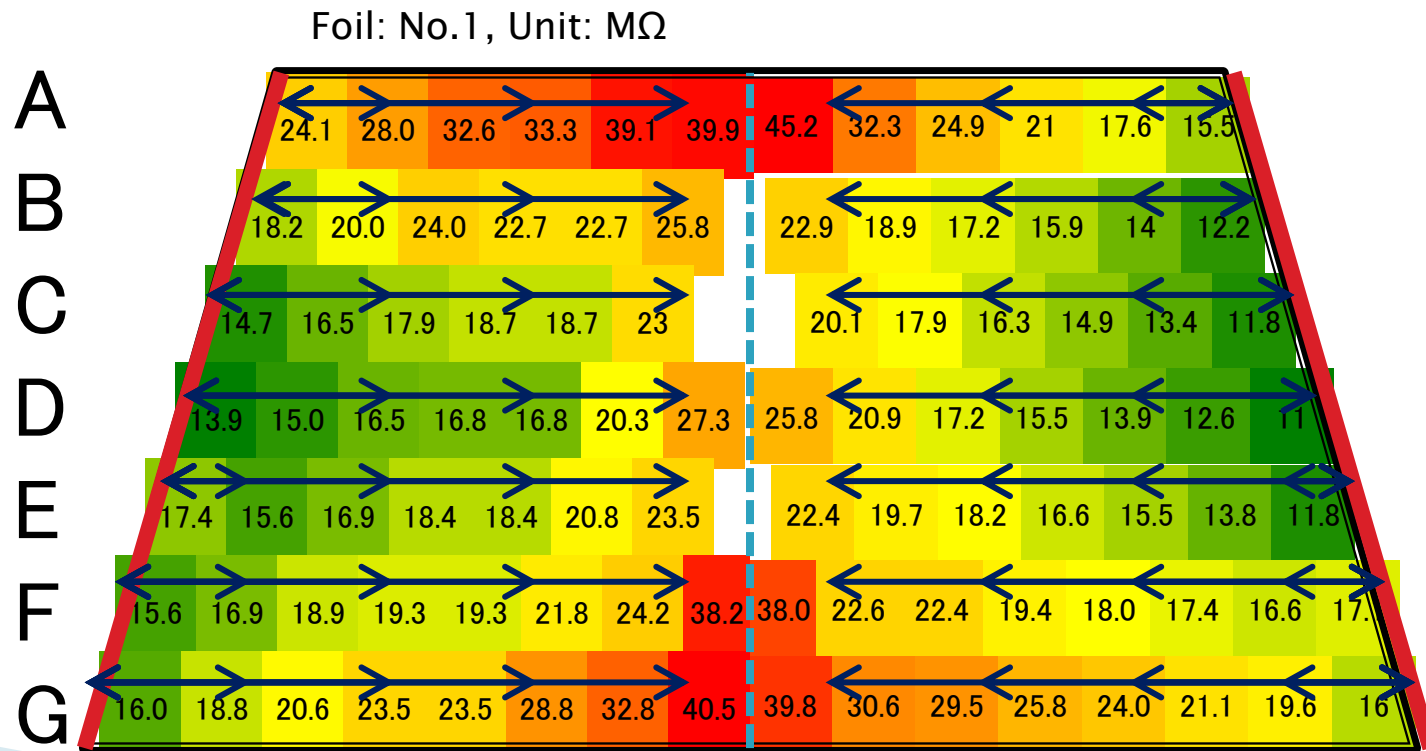


Unit: MΩ

No.	A	B	C	D	E
1	1.4	4	15	6	Inf
2	2.7	2.2	15	9.5	Inf
3	1.5	2.2	13.1	8.3	Inf
4	2.8	1.5	11	6.6	Inf
5	2.2	1.8	10.5	6.3	Inf
6	1.9	2.1	10	6.9	Inf
7	2.5	2.3	10.6	7.4	Inf
8	2.4	2.5	12.3	7.3	Inf

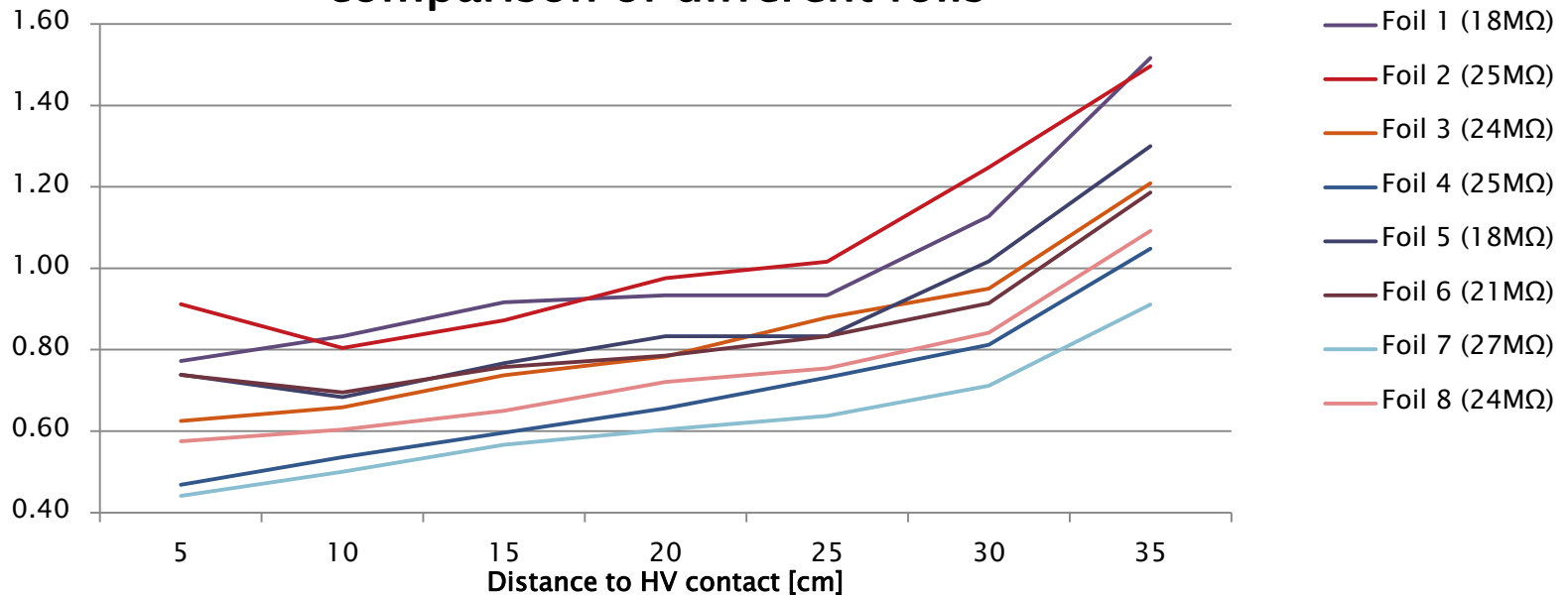
# Resistivity check

- ▶ Resistivity from edge to lattice point (5cm x 5cm) were measured (by Fabien Kuger).



# Comparison of different foils

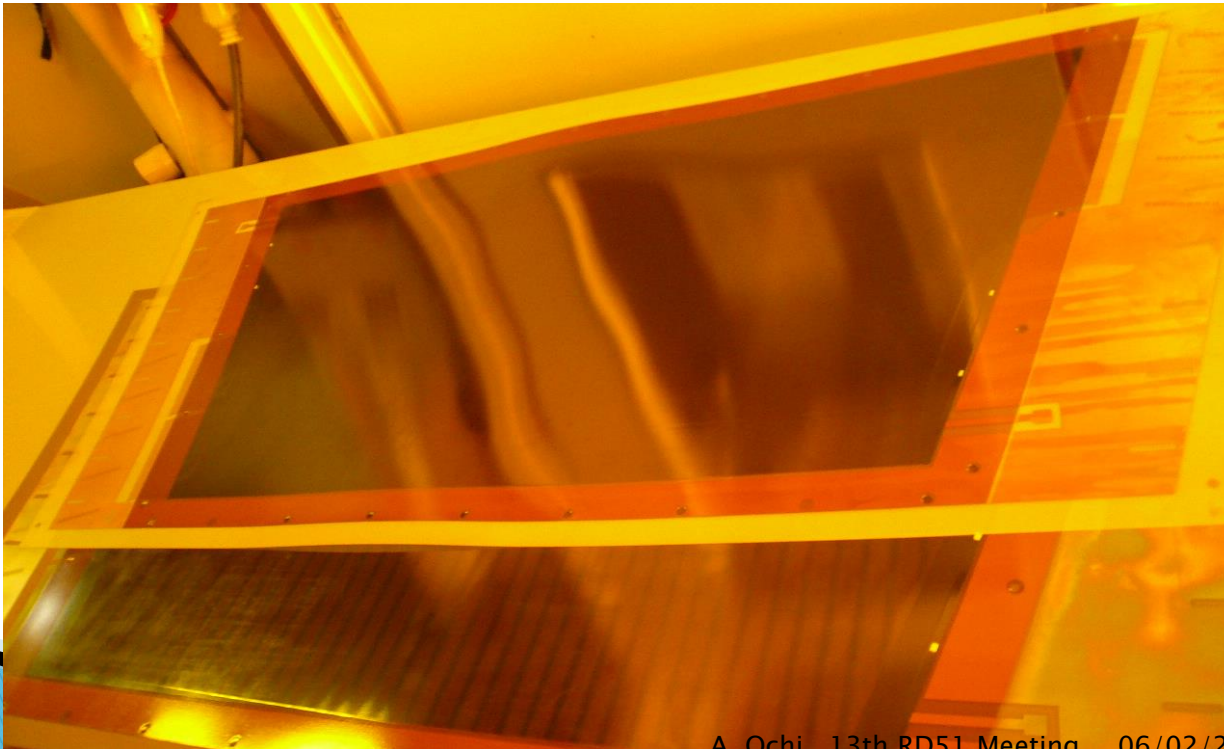
'Normalized' results along Line D (Side A)  
– comparison of different foils –



- ▶ Variability of ~ 30% were found for different foils
  - Reducing it is one of future issue

# With readout board

- ▶ 4 foils are attached to readout board successfully (at Rui's workshop)
  - For making quadruplet prototype (MSW)
  - Resistivity did not change after gluing
- ▶ Pillars will be formed soon



# Conclusion

- ▶ Sputtering technology is very promising for making MPGD resistive electrodes
  - Fine structure ( $\sim 10\mu\text{m}$ )
  - Large area ( a few meter)
- ▶ Prototype of MicroMEGAS using sputtered resistive electrodes were produced and tested.
  - It works as same as conventional resistive strip MicroMEGAS
  - Gain curve, operation in HIP were tested. It's OK.
- ▶ Carbon sputtering process is improved for ATLAS MicroMEGAS
  - Appropriate resistivity  $\sim 500\text{k}\Omega/\text{sq}$  with thick ( $3600\text{\AA}$ ) sputtering.
  - Good mechanical/chemical properties
- ▶ Large resistive strip foils ( $0.5\text{m} \times 1\text{m}$ ) are produced for functional prototype (MSW).
  - Qualitative resistivity check is ok.
  - The foils are already put on the readout board.
  - No resistivity change found before/after foil gluing.